

4. Hypothesis tests

Estimation: confidence intervals

Now: testing hypotheses against another

typical set-up:

H_0 *null hypothesis*

H_1 *alternative hypothesis*

Occam's razor: accept the simplest explanation unless evidence against it

H_0 typically is the simplest explanation

Thus testing is not symmetric: we would not like to reject H_0 unless the evidence against it is too strong

Paradox: Often one wants to establish a more complex explanation, hence seeks to reject H_0

Examples:

1. Toss a coin, either fair or biased .7 towards head

$$p = \mathbf{P}(\textit{Head})$$

$$H_0 : p = \frac{1}{2}$$

$$H_1 : p = 0.7$$

(symmetric problem)

2. Gender discrimination on jury selection?

$$p = \mathbf{P}(\textit{female})$$

$$H_0 : p = \frac{1}{2} : \text{no discrimination}$$

$$H_1 : p < \frac{1}{2}$$

3. *Swain vs. Alabama*, see

<http://www.stat.ucla.edu/cases/swain/>

Definition. A *statistical hypothesis* specifies a family of distributions of the observations

In our framework: a set of parameters; if $\theta \in \Theta$ is the whole parameter space, we would have

$$H_0 : \theta \in \Theta_0$$

$$H_1 : \theta \in \Theta_1$$

where $\Theta_0 \subset \Theta$, $\Theta_1 \subset \Theta$, and $\Theta_0 \cap \Theta_1 = \emptyset$

The hypothesis is *simple* if there is only one parameter value in the set, i.e. if it specifies the distribution completely; otherwise it is called *composite*

Test: Observe x_1, \dots, x_n , calculate test statistic $t(x_1, \dots, x_n)$; reject H_0 if t takes on a value that would be very unusual if H_0 was true

A test is equivalent to specifying a set C of sample values such that:

If $\mathbf{x} \in C$ then we reject H_0 in favour of H_1

This set C is called the *critical region* of the test.

Example Flip coin n times, let $x_i = 1$ if the coin lands head in the i th toss, and $x_i = 0$ if in the i th toss the coin lands tail

Assume that the coin flips are realizations of i.i.d. Bernoulli random variables with unknown probability p of success

Put

$$T = t(\mathbf{X}) = \sum_{i=1}^n X_i \sim \text{Bin}(n, p)$$

$$H_0 : p = \frac{1}{2}$$

$$H_1 : p = 0.7$$

Reject H_0 in favour of H_1 if T is large: $T > c$

Specify *level* α : Want c such that

$$\mathbf{P}_0(T > c) \leq \alpha$$

where \mathbf{P}_0 denotes the probability under H_0 , i.e.

here $\text{Bin}(n, \frac{1}{2})$

So want c such that

$$\sum_{k>c} \binom{n}{k} 2^{-n} = \alpha$$

Find c from Table; e.g. $n = 15, \alpha = 0.05$:

$\mathbf{P}_0(T > 11) = 0.018, \mathbf{P}_0(T > 10) = 0.059$, so

choose $c = 11$

Note: Under H_1 , $T \sim \text{Bin}(15, .7)$ and $\mathbf{P}_1(T > 11) = 0.297$ is not very large neither

Notation: \mathbf{P}_θ is the probability if θ is the true parameter

$$H_0 : \theta \in \Theta_0$$

$$H_1 : \theta \in \Theta_1$$

The *size* of the test is

$$\sup_{\theta \in \Theta_0} \mathbf{P}_\theta(C),$$

it is also called the *Type I error probability*

If the size of the test is α and if $\mathbf{x} \in C$, then we say that the test is *significant* at the $100(1 - \alpha)\%$ level

The *power* of the test is given by the curve

$$\mathbf{P}_\theta(C), \theta \notin \Theta_0$$

For H_1 simple, the *Type II error* is $1 - \text{power}$

Example

x_1, \dots, x_n random sample from $\mathcal{N}(\mu, \sigma^2)$, σ^2 known

$$H_0; \mu = \mu_0$$

$$H_1 : \mu \neq \mu_0$$

$$t(\mathbf{x}) = \frac{\bar{x} - \mu_0}{\sqrt{\sigma^2/n}}$$

then

$$1 - \alpha = \mathbf{P}_0(\bar{X} - z_{\alpha/2}\sqrt{\sigma^2/n} < \mu_0 < \bar{X} + z_{\alpha/2}\sqrt{\sigma^2/n})$$

so for a test of size α we can choose

$$\begin{aligned} C = & \{\mathbf{x} : \bar{x} > \mu_0 + z_{\alpha/2}\sqrt{\sigma^2/n}\} \\ & \cup \{\mathbf{x} : \bar{x} < \mu_0 - z_{\alpha/2}\sqrt{\sigma^2/n}, \infty\} \end{aligned}$$

Power: If $\mu_1 \neq \mu_0$,

$$P_{\mu_1}(C)$$

$$\begin{aligned} &= P_{\mu_1}(\bar{X} - z_{\alpha/2}\sqrt{\sigma^2/n} > \mu_0) \\ &\quad + P_{\mu_1}(\mu_0 > \bar{X} + z_{\alpha/2}\sqrt{\sigma^2/n}) \\ &= P_{\mu_1}(\bar{X} - \mu_1 > z_{\alpha/2}\sqrt{\sigma^2/n} + (\mu_0 - \mu_1)) \\ &\quad + P_{\mu_1}(\bar{X} - \mu_1 < -z_{\alpha/2}\sqrt{\sigma^2/n} + (\mu_0 - \mu_1)) \\ &= 1 - \Phi\left(z_{\alpha/2} + \frac{\mu_0 - \mu_1}{\sqrt{\sigma^2/n}}\right) \\ &\quad + \Phi\left(-z_{\alpha/2} + \frac{\mu_0 - \mu_1}{\sqrt{\sigma^2/n}}\right) \end{aligned}$$

increases with $|\mu_0 - \mu_1|$

Can adjust n such that the test has a specific power

Connection with confidence intervals:

A pivot can also be used as a test statistic

confidence interval = the set of parameters
which we do not reject

In previous example:

$$C = \{\mathbf{x} : \bar{x} > \mu_0 + z_{\alpha/2}\sqrt{\sigma^2/n}\} \\ \cup \{\mathbf{x} : \bar{x} < \mu_0 - z_{\alpha/2}\sqrt{\sigma^2/n}, \infty\}$$

So accept if $\mathbf{x} \in C^c$, i.e. if

$$\mu_0 - z_{\alpha/2}\sqrt{\sigma^2/n} < \bar{x} < \mu_0 + z_{\alpha/2}\sqrt{\sigma^2/n}$$

i.e. accept for all μ_0 for which

$$\bar{x} - z_{\alpha/2}\sqrt{\sigma^2/n} < \mu_0 < \bar{x} + z_{\alpha/2}\sqrt{\sigma^2/n}$$

Likelihood ratio tests

Example: Toss a coin n times, either fair or biased .7 towards head

$$p = \mathbf{P}(\text{Head}) = \mathbf{P}(X_i = 1)$$

$$H_0 : p = \frac{1}{2}$$

$$H_1 : p = 0.7$$

use *likelihood ratio (LR)*

$$\frac{L(\frac{1}{2}; \mathbf{x})}{L(0.7; \mathbf{x})}$$

reject if LR small

$$\text{Here: } t(\mathbf{x}) = \sum_{i=1}^n x_i$$

$$\begin{aligned} \frac{L(\frac{1}{2}; \mathbf{x})}{L(0.7; \mathbf{x})} &= \frac{\binom{n}{t} 2^{-n}}{\binom{n}{t} (0.7)^t (0.3)^{n-t}} \\ &= \left(\frac{1}{2}\right)^n \left(\frac{10}{3}\right)^n \left(\frac{3}{7}\right)^t \end{aligned}$$

reject if LR small: if t is large

General: H_0, H_1 simple

$$H_0 : \theta = \theta_0$$

$$H_1 : \theta = \theta_1$$

The *likelihood ratio* (LR) is

$$\lambda(\mathbf{x}) := \frac{L(\theta_0; \mathbf{x})}{L(\theta_1; \mathbf{x})}$$

The *likelihood ratio test* (LRT) rejects H_0 when $\lambda(\mathbf{x})$ small

Or: give the *p-value*

$$p = \mathbf{P}(\lambda(\mathbf{X}) < \lambda(\mathbf{x}) | \theta = \theta_0)$$

reject if *p-value* small

p-value is the probability to observe a LR this small or smaller when H_0 is true

Example

$\mathcal{N}(\mu, \sigma^2)$, with σ^2 known

$$H_0 : \mu = \mu_0$$

$H_1 : \mu = \mu_1$, where μ_1 is some fixed number;

assume $\mu_1 < \mu_0$

Fix level α

$$\lambda(\mathbf{x}) = \frac{(2\pi\sigma^2)^{-n/2} e^{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu_0)^2}}{(2\pi\sigma^2)^{-n/2} e^{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu_1)^2}}$$

LR small \iff log LR small:

$$\begin{aligned} \log LR &= -\frac{1}{2\sigma^2} \sum_{i=1}^n \{(x_i - \mu_0)^2 - (x_i - \mu_1)^2\} \\ &= -\frac{1}{2\sigma^2} \{2n\bar{x}(\mu_1 - \mu_0) + n(\mu_0^2 - \mu_1^2)\} \end{aligned}$$

as $\mu_1 < \mu_0$: $\log LR$ increases $\iff \bar{x}$ increases

so: reject H_0 if \bar{x} small

$$\alpha \leq \mathbf{P}_0(\bar{X} < k)$$

so: reject H_0 iff

$$\bar{X} < \mu_0 - z_\alpha \frac{\sigma}{\sqrt{n}}$$

Power:

$$1 - \Phi\left(\frac{\mu_0 - \mu_1}{\frac{\sigma}{\sqrt{n}}} - z_\alpha\right) \geq 1 - \Phi(-z_\alpha) = \alpha$$

increases if $\mu_0 - \mu_1$ increases

is a *one-sided test*

Sample-size calculation:

If we wanted to be near-certain to reject H_0 when $\mu = \mu_0 - \delta$, say, and have size 0.05, then we could fix n to force $power(\mu) = 0.99$ at $\mu = \mu_0 - \delta$: i.e.,

$$0.99 = 1 - \Phi(\delta\sqrt{n}/\sigma - 1.645)$$

This equation reduces to $2.326 = \delta\sqrt{n}/\sigma - 1.645$, so that

$$n = \sigma^2(1.645 + 2.326)^2/\delta^2$$

is the required sample size

Constructing good tests: The Neyman-Pearson Lemma

Neyman-Pearson Lemma: Suppose the LRT that rejects H_0 when $\lambda(\mathbf{x}) < c$ has significance level α . Then any other test which has significance level $\alpha^* \leq \alpha$ has power less or equal to that of the LRT.

I.e.: The LRT is most powerful among all tests of level α

Proof

Let $C = (-\infty, A)$ be the critical region of the LRT, power β

Pick any other test of level $\alpha^* \leq \alpha$; let C^* critical region, β^* its power
then

$$\begin{aligned}\beta^* - \beta &= P_1(\mathbf{X} \in C^*) - P_1(\mathbf{X} \in C) \\&= \int_{C^*} L(\theta_1, \mathbf{x}) d\mathbf{x} - \int_C L(\theta_1, \mathbf{x}) d\mathbf{x} \\&= \int_{C^* \cap C} L(\theta_1, \mathbf{x}) d\mathbf{x} + \int_{C^* \cap C^c} L(\theta_1, \mathbf{x}) d\mathbf{x} \\&\quad - \int_{C \cap C^*} L(\theta_1, \mathbf{x}) d\mathbf{x} - \int_{C \cap (C^*)^c} L(\theta_1, \mathbf{x}) d\mathbf{x} \\&= \int_{C^* \cap C^c} L(\theta_1, \mathbf{x}) d\mathbf{x} - \int_{C \cap (C^*)^c} L(\theta_1, \mathbf{x}) d\mathbf{x}.\end{aligned}$$

On C : $L(\theta_0, \mathbf{x}) < AL(\theta_1, \mathbf{x})$

On C^c : $L(\theta_0, \mathbf{x}) \geq AL(\theta_1, \mathbf{x})$,

for some $A > 0$. So

$$\begin{aligned} A(\beta^* - \beta) &\leq \int_{C^* \cap C^c} L(\theta_0, \mathbf{x}) d\mathbf{x} - \int_{C \cap (C^*)^c} L(\theta_0, \mathbf{x}) d\mathbf{x} \\ &= \int_{C^*} L(\theta_0, \mathbf{x}) d\mathbf{x} - \int_C L(\theta_0, \mathbf{x}) d\mathbf{x} \end{aligned}$$

(add and subtract $\int_{C \cap C^*} L(\theta_0, \mathbf{x}) d\mathbf{x}$) and so

$$A(\beta^* - \beta) \leq \alpha - \alpha^* \leq 0.$$

This finishes the proof.

Back to example: $\mathcal{N}(\mu, \sigma^2)$; σ^2 known

$H_0 : \mu = \mu_0$; $H_1 : \mu = \mu_1$, where $\mu_1 < \mu_0$

In LRT: reject H_0 iff

$$\bar{X} < \mu_0 - z_\alpha \frac{\sigma}{\sqrt{n}}$$

we only used that $\mu_1 < \mu_0$;

Neyman-Pearson Lemma gives: test is most powerful for all $\mu_1 < \mu_0$:

Test is *uniformly most powerful (UMP)*:

Let H_1 be a composite hypothesis. A test that is most powerful for *every* simple alternative in H_1 is said to be *uniformly most powerful*

Similarly: $\mathcal{N}(\mu, \sigma^2)$; σ^2 known

$H_0 : \mu = \mu_0$; $H_1 : \mu = \mu_1$, where $\mu_1 > \mu_0$

LRT: reject H_0 iff

$$\bar{X} > \mu_0 + z_\alpha \frac{\sigma}{\sqrt{n}}$$

so test is UMP for $H_0 : \mu = \mu_0$; $H_1 : \mu > \mu_0$

But $H_0 : \mu = \mu_0$; $H_1 : \mu \neq \mu_0$: there is no UMP test

instead: reject if $|\bar{x} - \mu_0| > z_{\alpha/2} \frac{\sigma}{\sqrt{n}}$

Quite often the case: tests are constructed which are good, but not optimal power on both sides of μ_0 : *two-sided tests*

Constructing good tests: composite hypotheses

Example: $\mathcal{N}(\mu, \sigma^2)$; test for $H_0 : \mu = \mu_0$; but σ^2 unknown:

is a *nuisance parameter*

General: $\theta = (\theta_1, \dots, \theta_q)$, each $\theta_i \in \mathbf{R}$; assume: take values in some open interval of \mathbf{R}

Θ parameter set

$$H_0 : \theta \in \Theta_0 = \{\theta : \theta_1 = \theta_1^0, \dots, \theta_r = \theta_r^0\}$$

first r parameter fixed, rest unconstrained

Definition: The *generalized likelihood ratio* is

$$\lambda(\mathbf{x}) = \frac{\sup_{\theta \in \Theta_0} L(\theta, \mathbf{x})}{\sup_{\theta \in \Theta} L(\theta, \mathbf{x})}$$

The expression $\sup_{\theta \in \Theta_0} L(\theta, \mathbf{x})$ is also called *profile likelihood*

The *generalized likelihood ratio test* rejects H_0 when $\lambda(\mathbf{x})$ is small

Note: Always $0 \leq \lambda(\mathbf{x}) \leq 1$ for the *generalized likelihood ratio*

Example

random sample from $\mathcal{N}(\mu, \sigma^2)$; σ^2 unknown,
test

$H_0 : \mu = \mu_0$ against $H_1 : \mu \neq \mu_0$

$\Theta_0 = \{\mu_0\} \times (0, \infty)$; $\dim \Theta_0 = 1$

$\Theta = \mathbf{R} \times (0, \infty)$, $\dim \Theta = 2$

$\theta = (\mu, \sigma^2)$

$$L(\theta, \mathbf{x}) = (2\pi\sigma^2)^{-n/2} e^{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu)^2}$$

For $\sup_{\theta \in \Theta_0} L(\theta, \mathbf{x})$: Under H_0 , the likelihood
is maximized for the m.l.e.

$$\hat{\sigma}_0^2 = \frac{1}{n} \sum_{i=1}^n (x_i - \mu_0)^2$$

In Θ , the likelihood is maximized for the m.l.e.s

$$\hat{\mu} = \bar{x}, \quad \hat{\sigma}^2 = \frac{1}{n} \sum_{i=1}^n (x_i - \bar{x})^2$$

Note that

$$\begin{aligned} L(\mu_0, \hat{\sigma}_0^2), \mathbf{x}) &= (2\pi\hat{\sigma}_0^2)^{-n/2} e^{-\frac{1}{2\hat{\sigma}_0^2} \sum_{i=1}^n (x_i - \mu_0)^2} \\ &= (2\pi\hat{\sigma}_0^2)^{-n/2} e^{-\frac{n}{2}} \end{aligned}$$

and similarly

$$\begin{aligned} L((\hat{\mu}, \hat{\sigma}^2), \mathbf{x}) &= (2\pi\hat{\sigma}^2)^{-n/2} e^{-\frac{1}{2\hat{\sigma}^2} \sum_{i=1}^n (x_i - \bar{x})^2} \\ &= (2\pi\hat{\sigma}^2)^{-n/2} e^{-\frac{n}{2}} \end{aligned}$$

So

$$\begin{aligned} \lambda(\mathbf{x}) &= \left\{ \frac{\sum_{i=1}^n (x_i - \bar{x})^2}{\sum_{i=1}^n (x_i - \mu_0)^2} \right\}^{\frac{n}{2}} \\ &= \left\{ \frac{\sum_{i=1}^n (x_i - \bar{x})^2}{\sum_{i=1}^n (x_i - \bar{x})^2 + n(\bar{x} - \mu_0)^2} \right\}^{\frac{n}{2}} \\ &= \left\{ 1 + \frac{(\bar{x} - \mu_0)^2}{1/n \sum_{i=1}^n (x_i - \bar{x})^2} \right\}^{-\frac{n}{2}} \end{aligned}$$

is monotone in $t^2(\mathbf{x})$, with t -statistic

$$t(\mathbf{x}) = \frac{\bar{x} - \mu_0}{s/\sqrt{n}}$$

Small if t^2 large, i.e. if $t < 0$ and small, or if $t > 0$ and large

Testing $H_0 : \mu = \mu_0$ using the two-sided t -test is equivalent to testing it with the generalized LRT

Moreover, expand

$$\begin{aligned} & -2 \log \lambda(\mathbf{x}) \\ &= -2 \left(-\frac{n}{2} \right) \log \left\{ 1 + \frac{(\bar{x} - \mu_0)^2}{1/n \sum_{i=1}^n (x_i - \bar{x})^2} \right\} \\ &\approx n \frac{(\bar{x} - \mu_0)^2}{1/n \sum_{i=1}^n (x_i - \bar{x})^2} \\ &= \left\{ \frac{\sqrt{n}(\bar{x} - \mu_0)^2}{\sqrt{1/n \sum_{i=1}^n (x_i - \bar{x})^2}} \right\}^2 \\ &\approx (t(\mathbf{x}))^2 \\ &\rightarrow \chi_1^2 \text{ in distribution} \end{aligned}$$

Wilks' Theorem: Under a few conditions, as $n \rightarrow \infty$, for the generalized LR $\lambda(\mathbf{x})$ we have, in distribution,

$$-2 \log \lambda(\mathbf{x}) \approx \chi_r^2,$$

where $r = \dim \Theta - \dim \Theta_0$

So: reject H_0 at 5 % level, e.g., if the observed value of $-2 \log \lambda$ was greater than $\chi_r^2(.95)$

In large samples, $-2 \log \lambda$ is an approximate pivot, and can be used to obtain an approximate confidence set

$$\{(\theta_1^0, \dots, \theta_r^0) : -2 \log \lambda(\mathbf{x}) < \chi_r^2(1 - \alpha)\}$$

When $r = 1$, and n large, the generalized LRT is equivalent to constructing a two-sided test based on the MLE; test of size α rejects H_0 when

$$|\hat{\theta}_1 - \theta_1^0| \sqrt{nI(\hat{\theta})} > z_{\alpha/2}$$

(compare to confidence intervals)

random sample from $\mathcal{N}(\mu, \sigma^2)$; μ known, σ^2 unknown, test $H_0 : \sigma^2 = \sigma_0^2$ against $H_1 : \sigma^2 \neq \sigma_0^2$

$$\Theta_0 = \{\sigma_0^2\}$$

$$\Theta = \{0, \infty\}$$

$$\theta = \sigma^2$$

$$L(\theta, \mathbf{x}) = (2\pi\sigma^2)^{-n/2} e^{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu)^2}$$

In Θ , the likelihood is maximized for the m.l.e.s

$$\hat{\sigma}^2 = \frac{1}{n} \sum_{i=1}^n (x_i - \mu)^2$$

Note that

$$L(\sigma_0^2, \mathbf{x}) = (2\pi\sigma_0^2)^{-n/2} e^{-\frac{1}{2\sigma_0^2} \sum_{i=1}^n (x_i - \mu)^2}$$

and

$$L(\hat{\sigma}^2, \mathbf{x}) = (2\pi\hat{\sigma}^2)^{-n/2} e^{-\frac{n}{2}}$$

So

$$\lambda(\mathbf{x}) = \left(\frac{\hat{\sigma}^2}{\sigma_0^2} \right)^{\frac{n}{2}} e^{-\frac{1}{2\sigma_0^2} \sum_{i=1}^n (x_i - \bar{x})^2 + \frac{n}{2}}$$

Put

$$t = \frac{1/n \sum_{i=1}^n (x_i - \mu)^2}{\sigma_0^2}$$

then

$$\lambda(\mathbf{x}) = t^{n/2} \exp \left\{ \frac{n}{2} t + \frac{n}{2} \right\}$$

and

$$-2 \log \lambda = n(t - 1 - \log t)$$

increases as t increases from 1, decreases as t decreases from 1, so:

reject H_0 if $|t - 1|$ large

Under H_0 , $T = t(\mathbf{X}) = \frac{(n-1)S^2}{\sigma_0^2} \sim \chi_n^2$

so two-tailed test at level α : reject H_0 is $t > \chi_n^2(\alpha/2)$ or $t < \chi_n^2(1 - \alpha/2)$

Example: Multinomial distribution:

n balls, m cells, probability p_i for cell i , $i = 1, \dots, m$, balls thrown independently

x_i is the count in cell i , $i = 1, \dots, m$

$$f(\mathbf{x}, (p_1, \dots, p_m; m)) = \binom{n}{x_1, \dots, x_m} p_1^{x_1} \dots p_m^{x_m}$$

Exercise: M.l.e. if $\hat{p}_i = \frac{x_i}{n}$, $i = 1, \dots, m$

$H_0 : p_i = p_i(\theta)$, $i = 1, \dots, m$

$H_1 : not$

$$\begin{aligned} \lambda(\mathbf{x}) &= \frac{p_1(\hat{\theta})^{x_1} \dots p_m(\hat{\theta})^{x_m}}{\hat{p}_1^{x_1} \dots \hat{p}_m^{x_m}} \\ &= \prod_{i=1}^m \left(\frac{p_i(\hat{\theta})}{\hat{p}_i} \right)^{x_i} \end{aligned}$$

and

$$\begin{aligned} -2 \log \lambda(\mathbf{x}) &= -2n \sum_{i=1}^m \hat{p}_i \log \left(\frac{p_i(\hat{\theta})}{\hat{p}_i} \right) \\ &= 2 \sum_{i=1}^m O_i \log \left(\frac{O_i}{E_i} \right), \end{aligned}$$

where $O_i = n\hat{p}_i = x_i$ observed count in cell i

$E_i = np_i(\hat{\theta})$ expected count in cell i if H_0 is true

If $\theta \in \mathbf{R}^k$ then $\dim \Theta = m - 1, \dim \Theta_0 = k$, so under H_0

in distribution

$$-2 \log \lambda(\mathbf{x}) \approx \chi_{m-1-k}^2$$

Taylor expansion:

$$x \log \left(\frac{x}{x_0} \right) \approx x - x_0 + \frac{1}{2}(x - x_0)^2 \frac{1}{x_0}$$

so

$$\begin{aligned} & -2 \log \lambda(\mathbf{x}) \\ & \approx 2n \sum_{i=1}^m (\hat{p}_i - p_i(\hat{\theta})) + n \sum_{i=1}^m \frac{(\hat{p}_i - p_i(\hat{\theta}))^2}{p_i(\hat{\theta})} \\ & = \sum_{i=1}^m \frac{(x_i - np_i(\hat{\theta}))^2}{np_i(\hat{\theta})} \\ & = \sum_{i=1}^m \frac{(O_i - E_i)^2}{E_i} \end{aligned}$$

is called *Pearson's Chisquare-Statistic*

Examples:

six-faced die, $m = 6$, $H_0 : p_i = 1/6, i = 1, \dots, m$
"the die is fair"

$H_0 : p_i = e^{-\lambda} \frac{\lambda^i}{i!}, i = 1, \dots, m - 1$ "Poisson"

Can be used to assess goodness of fit of distributional assumptions: next chapter.